

(54) Title of the invention : ENTROPY BASED REGION REDUCING GENETIC ALGORITHM FOR RELIABILITY REDUNDANCY ALLOCATION IN INTERVAL ENVIRONMENT

		(71)Name of Applicant : 1)SINHA MAHAPATRA, Biplab Address of Applicant :School of Applied Science and Humanities, Haldia Institute of Technology, ICARE Complex, HIT Campus, Hatiberia, Haldia, Purba Medinipur 721657, West Bengal, India Purba Medinipur ----- ----- 2)SINGHA MAHAPATRA, Ghanshaym 3)BERA, Mihir Baran 4)MONDAL, Manoj Kumar 5)Giri, SANTANAB 6)ROYMAHAPATRA, Gourisankar 7)CHAKRABORTY, Shuvendu 8)GHOSH, Debashis 9)SARKAR, Sutapa Name of Applicant : NA Address of Applicant : NA (72)Name of Inventor : 1)SINHA MAHAPATRA, Biplab Address of Applicant :School of Applied Science and Humanities, Haldia Institute of Technology, ICARE Complex, HIT Campus, Hatiberia, Haldia, Purba Medinipur 721657, West Bengal, India Purba Medinipur ----- ----- 2)SINGHA MAHAPATRA, Ghanshaym Address of Applicant :Department of Mathematics, National Institute of Technology, Puducherry, Karaikal 609609, Puducherry, India Karaikal ----- 3)BERA, Mihir Baran Address of Applicant :School of Applied Science and Humanities, Haldia Institute of Technology, ICARE Complex, HIT Campus, Hatiberia, Haldia, Purba Medinipur 721657, West Bengal, India Purba Medinipur ----- ----- 4)MONDAL, Manoj Kumar Address of Applicant :School of Applied Science and Humanities, Haldia Institute of Technology, ICARE Complex, HIT Campus, Hatiberia, Haldia, Purba Medinipur 721657, West Bengal, India Purba Medinipur ----- ----- 5)Giri, SANTANAB Address of Applicant :School of Applied Science and Humanities, Haldia Institute of Technology, ICARE Complex, HIT Campus, Hatiberia, Haldia, Purba Medinipur 721657, West Bengal, India Purba Medinipur ----- ----- 6)ROYMAHAPATRA, Gourisankar Address of Applicant :School of Applied Science and Humanities, Haldia Institute of Technology, ICARE Complex, HIT Campus, Hatiberia, Haldia, Purba Medinipur 721657, West Bengal, India Purba Medinipur ----- ----- 7)CHAKRABORTY, Shuvendu Address of Applicant :Xavier Business School, ST. Xavier's University, Action Area III B, New Town , Kolkata 700 160, West Bengal, India Kolkata ----- 8)GHOSH, Debashis Address of Applicant :Department of Mathematics, University of Petroleum and Energy Studies, Dehradun 248007 , Uttarakhand India Dehradun ----- 9)SARKAR, Sutapa Address of Applicant :Cyber Science & Technology, School of Computational and Applied Sciences, Brainware University, 398, Ramkrishnapur Rd, near Jagadighata Market, Barasat, Kolkata 700125, West Bengal, India Kolkata -----	
(51) International classification	:G06N0003126000, G06Q0010040000, G06Q0010063900, G06N0007010000, G06Q0010060000		
(86) International Application No	:NA		
Filing Date	:NA		
(87) International Publication No	: NA		
(61) Patent of Addition to	:NA		
Application Number	:NA		
Filing Date	:NA		
(62) Divisional to Application	:NA		
Number	:NA		
Filing Date	:NA		

(57) Abstract :
ENTROPY BASED REGION REDUCING GENETIC ALGORITHM FOR RELIABILITY REDUNDANCY ALLOCATION IN INTERVAL ENVIRONMENT Embodiments present a multi-objective reliability redundancy allocation problem for optimum system reliability and system cost with limitation on entropy of the system which is very essential for effective sustainability. Both crisp and interval-valued system parameters are considered for better realization of the model in more realistic sense. Embodiments propose that the system cost of the redundancy allocation problem depends on reliability of the components. A subpopulation and entropy-based region reducing genetic algorithm (GA) with Laplace crossover and power mutation is proposed to determine the optimum number of redundant components at each stage of the system. The approach is demonstrated through the case study of a break lining manufacturing plant. A comprehensive study is conducted for comparing the performance of the proposed GA with the single-population based standard GA by evaluating the optimum system reliability and system cost with the optimum number of redundant components. Set of numerical examples are provided to illustrate the effectiveness of the redundancy allocation model based on the proposed optimization technique. We present a brief discussion on change of the system using graphical phenomenon due to the changes of parameters of the system. Comparative performance studies of the proposed GA with the standard GA demonstrate that the proposed GA is promising to solve the reliability redundancy optimization problem providing better optimum system reliability. FIGURE 1, 2